

WMM7035DBUJ0

Bottom port digital silicon Microphone

Descriptions

WMM7035DBUJ0 is a Silicon Microphone with digital output and bottom inlet for sound input. It consists of a MEMS sensor and an encoder IC. It converts sensor analog output signal into 1-bit digital PDM data. The digital output format eliminates AC coupling capacitor, reduces RF noise coupling and eases PCB layout requirement.

WMM7035DBUJ0 is a cost-effective alternative to traditional electret condenser microphone (ECM). Provided on tap-and-reel, it is ideally suited for high volume applications. And it can be processed directly to customer's PCB using standard automatic pick-and-place equipment and surface mounted via standard solder reflow equipment.

WMM7035DBUJO can be used to implement the array microphones. Speech quality can be significantly improved by combining two microphones.

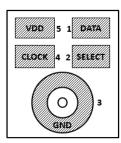
The WMM7035DBUJ0 is manufactured in a compact 3.50mm*2.65mm*0.98mm, 5-pin package.

Features

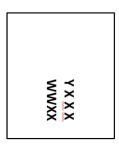
- PDM Output
- High SNR
- Multiple performance modes
- Ultra-Stable Performance
- Standard SMD Reflow
- RoHS/Halogen free compliant
- Omnidirectional

Applications

- Smart phones
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- Portable communication device
- Notebook and desktop
- Digital still cameras
- Portable music recorders



Pin configuration (Bottom view)



Marking (Top view)

Y = Year code WW = Week code X X = Data code

kers	Device	Package(mm)	Shipping
	WMM7035DBUJ0- 5/TR	3.50*2.65*0.98	5000 ¹⁹ Tape
	Ord	er information	
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Absolute Maximum Ratings

Parameter	Maximum Ratings	Unit
Power supply voltage	6.5	V
Operation temperature range	-40~85	V
Storage temperature range	-40~125	°C

Stresses at the maximum ratings shown in Table 1 may cause permanent damage to the device. These are stress ratings only at which the device may not function when an operation at these or any other condition beyond those specified under "Electro-Acoustic Specifications".





Acoustic & Electrical Specifications

Normal Mode Electrical Specifications

Test condition: +25±2°C, 60% \sim 70% RH, 86~106Kpa, F_{CLK}=2.4MHz, V_{DD}=1.8V, no load, unless otherwise noted.

Symbol	Description	Min.	Тур.	Max.	Units
Fclk	Clock Frequency	1.3	2.4	4.8	MHz
lod	Supply Current ¹		770	900	uA
S	Sensitivity ³ , 94dB SPL@1KHz	-27	-26	-25	dBFS ²
ΔS	Sensitivity drop	<0.5			dBFS
	20-5KHz Bandwidth, A-Weighted		68		dB(A)
SNR	20-8KHz Bandwidth, A-Weighted		66.5		dB(A)
	20-20KHz Bandwidth, A-weighted	63	65		dB(A)
	94dB SPL@1KHz		0.15	0.5	%
THD	118dB SPL@1KHz		1		%
AOP	10%THD@1KHz		121		dBSPL
PSR	Measured with 217Hz,100mVpp square wave		-90	-80	dBFS
PSRR	Measured with 1KHz,200mVpp sinewave		60		dBFS

Low Power Mode Electrical Specifications

Test condition: +25±2°C, 60% \sim 70% RH, 86~106Kpa, F_{CLK}=768KHz, V_{DD}=1.8V, no load, unless otherwise noted.

IDD Supple S Sensi ΔS Sensi	<pre>K Frequency</pre>	150		1	
S Sensi ΔS Sensi			768	900	KHz
ΔS Sensi	ly Current		340	450	uA
	itivity, 94dB SPL@1KHz	-27	-26	-25	dBFS
SNR 20Hz	itivity drop	<0.5			dBFS
	~8KHz Bandwidth, A-weighted		64		dB(A)
	SPL@1KHz		0.15	0.5	%
THD 118dE	B SPL@1KHz		1		%
AOP 10%T	THD@1KHz		120		dBSPL
PSR Meas	sured with 217Hz, 100mV _{pp} square wave		-90	-80	戌理 Ⅰ原素
PSRR Meas	sured with 1KHz,200mVpp sinewave		60	想	

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- Note 1: The current consumption depends on the applied clock frequency and the load on the DATA output
- Note 2: dBFS=20*logA/B, where A is the level of signal, and B is the level that corresponds to full-scale level
- Note 3: Relative to the rms level of a sine wave with positive amplitude equal to100%1s density and Negative amplitude equal to 0% 1s density
- Note 4: Frequency response, sensitivity and current consumption are tested by 100% on product line.

General Electrical Specifications

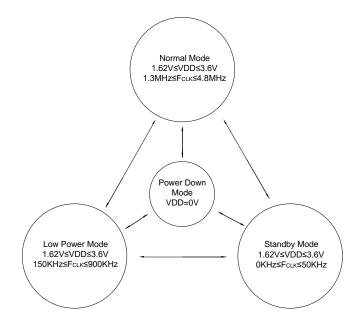
Test condition: +25±2℃, 60%~70% RH, 86~106Kpa, no load, unless otherwise noted.

Symbol	Description	Description		Тур.	Max.	Units
V _{DD}	Supply Voltage		1.62	1.8	3.6	V
ISLEEP	Power Consumption FCLK<50KHzor CLK (6	50	uA
		Standby Mode			50	KHz
Fclk	Clock Frequency	Low Power Mode	150	768	900	KHz
		Normal Mode	1.3	2.4	4.8	MHz
Data Format			1/2 Cycle PDM			
Directivity				irectional		
Polarity	Increasing sound pre-	Increasing sound pressure			y of 1's	
Isc	Short circuit current,	Short circuit current, Grounded DATA			20	mA
CLOAD	Load capacitance	Load capacitance			100	pF
Reset time	Time to start up in an been off for more that remained on			20	ms	
Start-up time	Start-up into normal r			20	ms	
Mode-switch time	Mode-switch Normal mode to Normal mod	mode to LP mode or LP e			20	ms

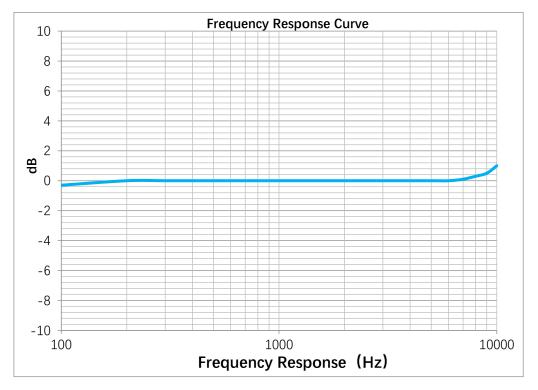




Microphone State Diagram



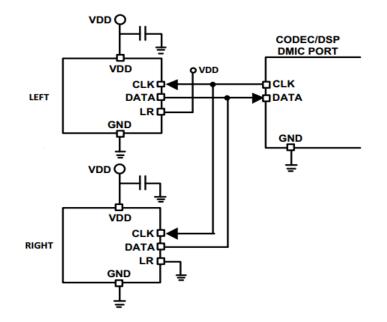
Frequency Response Curve





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Application Information

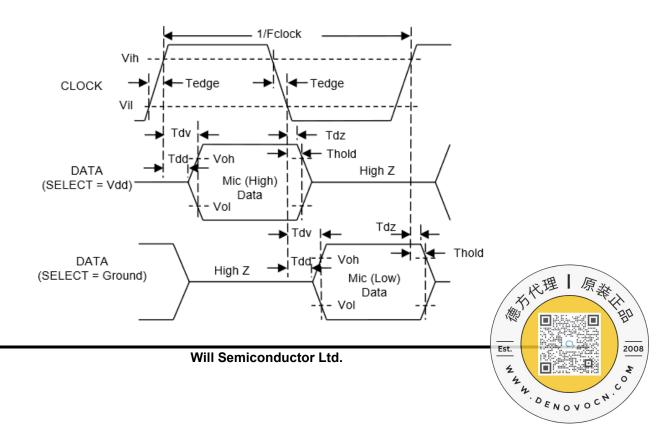


Microphone	SELECT	Asserts DATA On	Latch DATA On
Mic (High)	V _{DD}	Rising Clock Edge	Falling Clock Edge
Mic (Low)	GND	Falling Clock Edge	Rising Clock Edge

Note:

- All GND pins must be connected to ground.
- Capacitors near the microphone should not contain Class 2 dielectrics.

Clock Timing Diagram





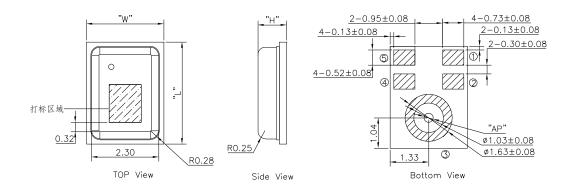
Timing Characteristics

Parameter	Symbol	Min.	Тур.	Max.	Unit	Note
Clock duty cycle		40	50	60	%	
Operation Voltage	V _{DD}	1.62		3.6	V	
Input Logic Low Level	VIL	-0.3		0.35×V _{DD}	V	
Input Logic High Level	VIH	0.65×V _{DD}		V _{DD} +0.3	V	
Output Logic Low Level	Vol			0.45	V	
Output Logic High Level	Vон	V _{DD} -0.45			V	
Clock rise time	t _{CR}			6	ns	35%~65%
Clock fall time	tcF			6	ns	65%~35%
Delay time for data valid	t _{DV}	40		100	ns	Delay time from clock edge(0.50 x VDD) to data valid(<v<sub>OL or > V_{OH})</v<sub>
Delay time for data driven	tod	25		50	ns	Delay time from clock edge (50% VDD) to data driven.
Delay time for data high Z	t _{Hz}	5		20	ns	Delay time from clock edge(50% VDD) to data





Mechanical Specifications



Item	Dimension	Tolerance
Length(L)	3.50	±0.10
Width(W)	2.65	±0.10
Height(H)	0.98	±0.10
Acoustic Port (AP)	Ø0.325	±0.05

Pin#	Pin Name	Description
1	DATA	PDM Output
2	SELECT	Lo/Hi (L/R) Select
2	SELECT	This pin is internally pulled low but should not be left floating.
3	GND	GND
4	CLOCK	Clock input
5	VDD	Power Supply

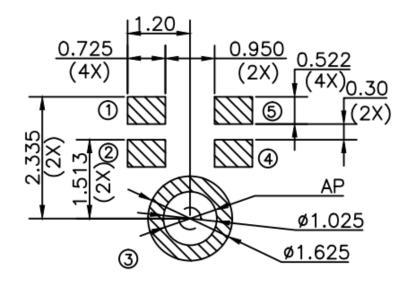
Notes:

- Dimensions are in millimeters unless otherwise specified.
- Tolerance is ±0.10mm unless otherwise specified.
- Pick Area only extends to 0.25 mm of any edge or hole unless otherwise specified.
- Suggestion to use the same date code microphone in one array microphone module.

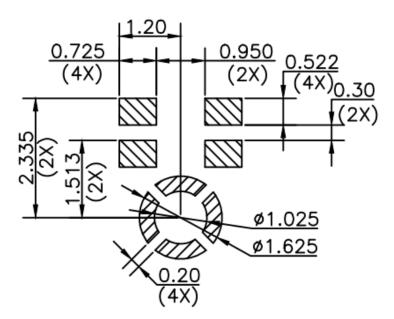


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Example Land Pattern



Example Solder Stencil Pattern



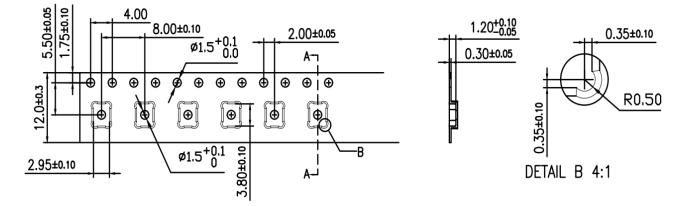
Notes: Dimensions are in millimeters unless otherwise specified. Further optimizations based on application should be performed.



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Packaging & Marking Detail



Pin 1	$\rightarrow \phi$	
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Model Number	Reel Diameter	Quantity Per Reel
WMM7035DBUJ0	13"	5,000

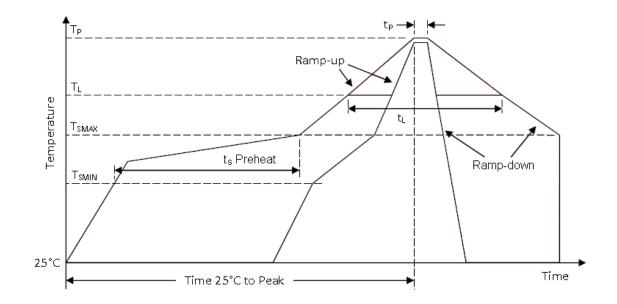
Notes:

- Dimensions are in millimeters unless otherwise specified.
- Vacuum pickup only in the pick area indicated in Mechanical Specifications.
- Tape & reel per EIA-481.
- Labels applied directly to reel and external package.





Referenced Reflow Profile



Profile Feature	Pb-Free
Average Ramp-up rate (TSMAX to TP)	3°C/second max.
Preheat • Temperature Min (Tsmin) • Temperature Max (Tsmax) • Time (Tsmin to Tsmax) (ts)	150°C 200°C 60-180 seconds
Time maintained above: • Temperature (Τι) • Time (tι)	217°C 60-150 seconds
Peak Temperature (T _P)	260°C
Time within 5°C of actual Peak Temperature (t _P)	20-40 seconds
Ramp-down rate (TP to TSMAX)	6°C/second max
Time 25°C to Peak Temperature	8 minutes max

Note:

All temperatures refer to topside of the package, measured on the package body surface.





Additional Notes

(A) Maximum of 3 reflow cycles is recommended.

- (B) In order to minimize device damage:
 - Do not board wash or clean after the reflow process.
 - Do not brush board with or without solvents after the reflow process.
 - Do not directly expose to ultrasonic processing, welding, or cleaning.
 - Do not insert any object in port hole of device at any time.
 - Do not apply over 30 psi of air pressure into the port hole.
 - Do not pull a vacuum over port hole of the microphone.
 - Do not apply a vacuum when repacking into sealed bags at a rate faster than 0.5 atm/sec.

Materials Statement

Meets the requirements of the European RoHS and Halogen-Free.

Test	Description
Thermal Shock	100 cycles air-to-air thermal shock from -40°C to +125°C with 15 minute soaks. (IEC 68-2-4)
High Temperature Storage	1000 hours at +105°C environment. (IEC 68-2-2 Test Ba)
Low Temperature Storage	1000 hours at -40°C environment. (IEC 68-2-2 Test Aa)
High Temperature Bias	1000 hours at +105°C under bias. (IEC 68-2-2 Test Ba)
Low Temperature Bias	1000 hours at -40°C under bias. (IEC 68-2-2 Test Aa)
Temperature / Humidity Bias	1000 hours at +85°C /85% R.H. under bias. (JESD22-A101A-B)
Vibration	4 cycles of 20 to 2,000 Hz sinusoidal sweep with 20g peak acceleration lasting 12
	minutes in X, Y, and Z directions. (Mil-Std-883E, method 2007.2 A)
ESD-HBM	3 discharges of ±3.5kV direct contact to I/O pins. (ESD STM5.2)
ESD-LID/GND	3 discharges of ±8 kV direct contact to lid while unit is grounded. (IEC 61000-4-2)
ESD-MM	3 discharges of ±200V direct contact to I/O pins. (ESD STM5.2)
Reflow	5 reflow cycles with peak temperature of +260°C.
Mechanical Shock	3 pulses of 10000g in the X, Y, and Z direction. (IEC 68-2-27, Test Ea)
Drop Test	To be no interference in operation after dropped to marble or 1.0cm steel plate
	18 times from 1.5 meter height.

Reliability Specifications

Note:

After reliability tests are performed, the sensitivity of the microphones shall not deviate more than 3 dB from its initial value. (The measurement to be done after 2 hours of conditioning at 20 \pm 2 °C, R.H 60% \sim 70%)

